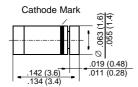
LL42, **LL43**

Schottky Diodes

MiniMELF



Dimensions in inches and (millimeters)

FEATURES

- ♦ For general purpose applications.
- ◆ These diodes feature very low turnon voltage and fast switching. These devices are protected by a PN junction guard ring against excessive voltage, such as electrostatic discharges.
- ◆ These diodes are also available in the DO-35 case with type designations BAT42 to BAT43 and in the SOD-123 case with type designations BAT42W to BAT43W.

MECHANICAL DATA

Case: MiniMELF Glass Case (SOD-80)

Weight: approx. 0.05 g

MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Ratings at 25 °C ambient temperature unless otherwise specified

	Symbol	Value	Unit	
Repetitive Peak Reverse Voltage	V _{RRM}	30	V	
Forward Continuous Current at T _{amb} = 25 °C	I _F	2001)	mA	
Repetitive Peak Forward Current at $t_p < 1$ s, $\delta < 0.5$, $T_{amb} = 25$ °C	I _{FRM}	5001)	mA	
Surge Forward Current at t _p < 10 ms, T _{amb} = 25 °C	I _{FSM}	41)	А	
Power Dissipation at T _{amb} = 65 °C	P _{tot}	2001)	mW	
Junction Temperature	Tj	125	°C	
Ambient Operating Temperature Range	T _{amb}	-55 to +125	°C	
Storage Temperature Range	T _S	-65 to +150	°C	



LL42, LL43

ELECTRICAL CHARACTERISTICS

Ratings at 25 °C ambient temperature unless otherwise specified

		Symbol	Min.	Тур.	Max.	Unit
Reverse Breakdown Voltage tested with 100 μA Pulses		V _{(BR)R}	30	_	_	V
Forward Voltage Pulse Test $t_p < 300~\mu s$, $\delta < 2\%$ at $I_F = 200~m A$ at $I_F = 10~m A$ at $I_F = 50~m A$ at $I_F = 2~m A$ at $I_F = 15m A$	LL42 LL42 LL43 LL43	V _F V _F V _F V _F	- - - 0.26	- - - -	1 0.4 0.65 0.33 0.45	V V V V
Leakage Current Pulse Test $t_p < 300~\mu s, \delta < 2\%$ at $V_R = 25~V$ at $V_R = 25~V, T_j = 100~^{\circ}C$		I _R	_ _ _		0.5 100	μΑ μΑ
Capacitance at V _R = 1 V, f = 1 MHz		C _{tot}	_	7	_	pF
Reverse Recovery Time from $I_F = 10$ mA through $I_R = 10$ mA to $R_L = 100 \Omega$	o I _R = 1 mA,	t _{rr}	_	-	5	ns
Rectification Efficiency at R_L = 15 $K\Omega$, C_L = 300 pF, f = 45 MHz, V_{RF} = 2 V		ην	80	-	-	%
Thermal Resistance Junction to Am	bient Air	R _{thJA}	_	_	0.31)	K/mW

¹⁾ Valid provided that electrodes are kept at ambient temperature.

